

IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology
- 180µm chip
- short circuit prove
- positive temperature coefficient
- · easy paralleling

This chip is used for:

 IGBT-Modules BSM150GB120DLC

BSM150GB120DLC Applications: drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC223T120R2CL	1200V	150A	14.4 x 15.5 mm ²	sawn on foil	Q67050-A4286- A101

MECHANICAL PARAMETER:

MECHANICAL PARAMETER: Raster size	14.4 x 15.5	mm²	
Area total / active	223.2 / 189.9		
Emitter pad size	8x(3.67x6.77)		
Gate pad size	1.49 x 1.51	_	
Thickness	180	μm	
Wafer size	150	mm	
Flat position	90	deg	
Max.possible chips per wafer	54 pcs		
Passivation frontside	Photoimide		
Emitter metalization	3200 nm Al Si 1%		
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	AI, ≤500μm		
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	450	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_i =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter			min.	typ.	max.	0
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} =8 mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.8	2.2	2.6	V
Gate-emitter threshold voltage	V _{GE(th)}	I _C =6mA , V _{GE} =V _{CE}	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			900	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			600	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Canditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Oiiii
Input capacitance	Ciss	V _{CE} =25V,	-	11	-	nF
Output capacitance	Coss	$V_{GE}=0V$,	-	-	-	
Reverse transfer capacitance	Crss	f=1MHz	-	0.7	-	

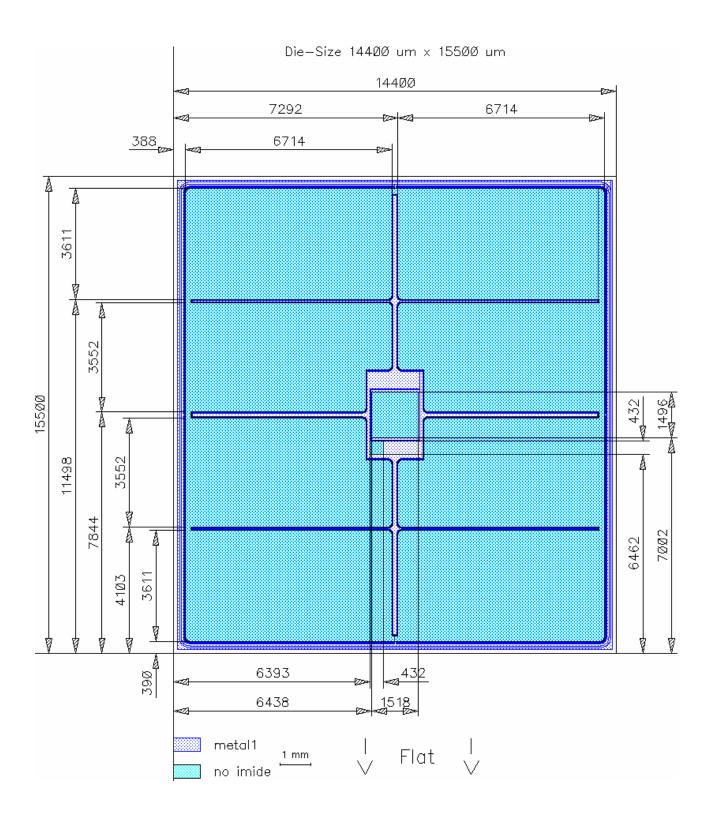
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
raiametei			min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	T _j =125°C	-	50	-	ns
Rise time	t _r	$V_{\rm CC} = 600 \text{V},$ $I_{\rm C} = 150 \text{A}$	-	50	-	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =±15V, $R_{\rm G}$ =5.6 Ω	-	570	-	
Fall time	t_{f}	, r.g. = 0 . 032	-	40	-	

 $^{^{1)}}$ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	BSM150GB120DLC	Half-Bridge 62mm
device data sileet		

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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